

<b>Notice of References Cited</b>	Application/Control No. 09/887,831	Applicant(s)/Patent Under Reexamination BATTIN ET AL.	
	Examiner Ajay M. Bhatia	Art Unit 2145	Page 1 of 2

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<b>Notice of References Cited</b>	Application/Control No. 09/887,831	Applicant(s)/Patent Under Reexamination BATTIN ET AL.	
	Examiner Ajay M. Bhatia	Art Unit 2145	Page 2 of 2

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